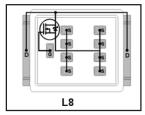
International IOR Rectifier

AUTOMOTIVE GRADE

AUIRF7739L2TR AUIRF7739L2TR1

Automotive DirectFET® Powe	r MOSFET ②
$V_{(BR)DSS}$	40V
R _{DS(on)} typ.	700μ Ω
max.	1000μΩ

270A D (Silicon Limited) 220nC





Features

- Advanced Process Technology
- · Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- · Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- · Lead free, RoHS Compliant and Halogen free
- Automotive Qualified*

Applicable DirectFET® Outline and Substrate Outline ①

SB SC	M2	М4		L4	L6	L8	
-------	----	----	--	----	----	----	--

Description

The AUIRF7739L2TR(1) combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve the lowest on-state resistance in a package that has the footprint of a DPak (TO-252AA) and only 0.7 mm profile. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are essential. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF7739L2TR(1) to offer substantial system level savings and performance improvement specifically in motor drive, high frequency DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T₄) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V _{DS}	Drain-to-Source Voltage	40	V
V _{GS}	Gate-to-Source Voltage	± 20	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	270	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	190	А
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)3	46	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	375	
I _{DM}	Pulsed Drain Current ④	1070	
P _D @T _C = 25°C	Power Dissipation ®	125	w
P _D @T _A = 25°C	Power Dissipation ③	3.8	VV
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ®	270	mJ
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ^⑤	160	
I _{AR}	Avalanche Current ⑤	See Fig.12a, 12b, 15, 16	А
E _{AR}	Repetitive Avalanche Energy ^⑤		mJ
T _P	Peak Soldering Temperature	270	
TJ	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		

Thermal Resistance

Thermal nesistance								
	Parameter	Тур.	Max.	Units				
$R_{\theta JA}$	Junction-to-Ambient ③		40					
$R_{\theta JA}$	Junction-to-Ambient ®	12.5						
$R_{\theta JA}$	Junction-to-Ambient ®	20		°C/W				
$R_{\theta JCan}$	Junction-to-Can ⊕®		1.2					
$R_{\theta J\text{-PCB}}$	Junction-to-PCB Mounted		0.5					
	Linear Derating Factor ⁽⁴⁾	0.	0.83					

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Characteristics @ T_J = 25°C (unless otherwise stated)

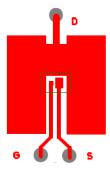
	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.008		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		700	1000	μΩ	V _{GS} = 10V, I _D = 160A ⑦
V _{GS(th)}	Gate Threshold Voltage	2.0	2.8	4.0	٧	$V_{DS} = V_{GS}, I_D = 250 \mu A$
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Coefficient		-6.7		mV/°C	
gfs	Forward Transconductance	280			S	$V_{DS} = 10V, I_D = 160A$
R _G	Gate Resistance		1.5		Ω	
I _{DSS}	Drain-to-Source Leakage Current			5.0	μΑ	$V_{DS} = 40V, V_{GS} = 0V$
				250		$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100		V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Characteristics @ T_J = 25°C (unless otherwise stated)

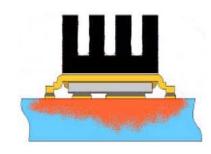
_	Parameter	Min.	Тур.	Max.	Units	Conditions
Q _g	Total Gate Charge		220	330		$V_{DS} = 20V, V_{GS} = 10V$
Q _{gs1}	Pre-Vth Gate-to-Source Charge		46		1	I _D = 160A
Q _{gs2}	Post-Vth Gate-to-Source Charge		19		nC	See Fig. 11
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	81			
Q_{godr}	Gate Charge Overdrive	—	74			
Q _{sw}	Switch Charge (Q _{gs2} + Q _{gd})		100		1	
Q _{oss}	Output Charge	—	83		nC	$V_{DS} = 16V, V_{GS} = 0V$
t _{d(on)}	Turn-On Delay Time		21			V _{DD} = 20V, V _{GS} = 10V ⑦
t _r	Rise Time		71		ns	I _D = 160A
t _{d(off)}	Turn-Off Delay Time		56			$R_G = 1.8\Omega$
t _f	Fall Time		42		1	
C _{iss}	Input Capacitance		11880			$V_{GS} = 0V$
C _{oss}	Output Capacitance		2510		1	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		1240		pF	f = 1.0 MHz
C _{oss}	Output Capacitance		8610		1	$V_{GS} = 0V, V_{DS} = 1.0V, f=1.0MHz$
C _{oss}	Output Capacitance		2230		1	$V_{GS} = 0V, V_{DS} = 32V, f=1.0MHz$
C _{oss} eff.	Effective Output Capacitance		3040		1	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V$

Diode Characteristics @ T_J = 25°C (unless otherwise stated)

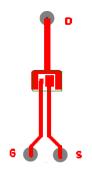
	Parameter	Min.	Typ.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			110		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ⑤			1070		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	I _S = 160A, V _{GS} = 0V ⑦
t _{rr}	Reverse Recovery Time		87	130	ns	$I_F = 160A, V_{DD} = 20V$
Q _{rr}	Reverse Recovery Charge	I	250	380	nC	di/dt = 100A/µs ⑦



③ Surface mounted on 1 in. square Cu (still air).



Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

Qualification Information[†]

		Automotive			
		(per AEC-Q101) ^{††}			
Qualification Level		Comments: This part number(s) passed Automotive qualification IR's Industrial and Consumer qualification level is granted b extension of the higher Automotive level.			
Moisture Sensitivity	Level	DFET2 MSL1			
	Machine Model	Class M4 (800V)			
			AEC-Q101-002		
	Human Body Model		Class H3A (7000V)		
ESD			AEC-Q101-001		
	Charged Device		N/A		
	Model	AEC-Q101-005			
RoHS Compliant		Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com

www.irf.com 3

^{††} Exceptions to AEC-Q101 requirements are noted in the qualification report.

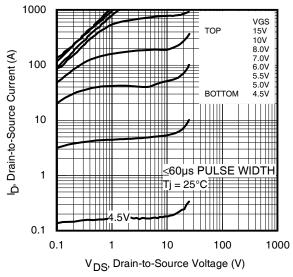


Fig 1. Typical Output Characteristics

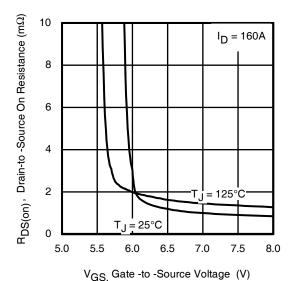


Fig 3. Typical On-Resistance vs. Gate Voltage

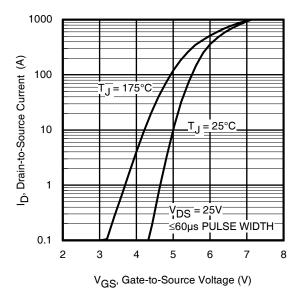


Fig 5. Typical Transfer Characteristics

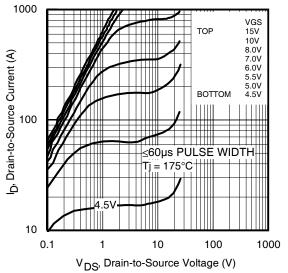


Fig 2. Typical Output Characteristics

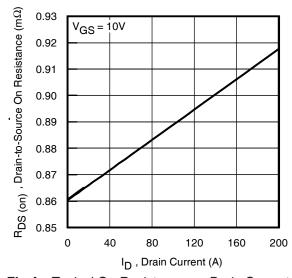


Fig 4. Typical On-Resistance vs. Drain Current

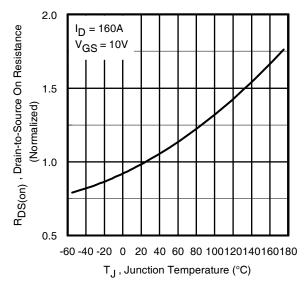


Fig 6. Normalized On-Resistance vs. Temperature www.irf.com

International

Fig 7. Typical Threshold Voltage vs. Junction Temperature

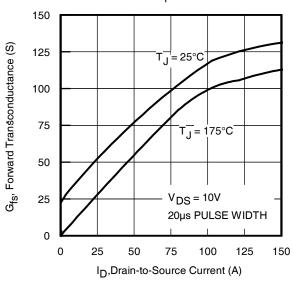


Fig 9. Typical Forward Transconductance vs. Drain Current

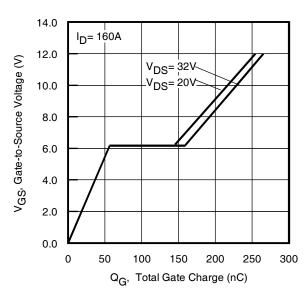


Fig.11 Typical Gate Charge vs.Gate-to-Source Voltage www.irf.com

AUIRF7739L2TR/TR1

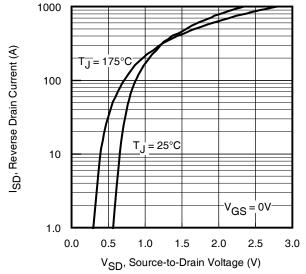


Fig 8. Typical Source-Drain Diode Forward Voltage

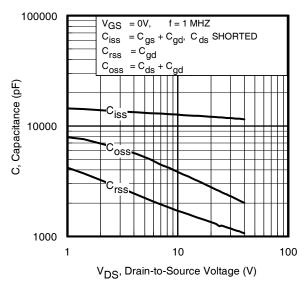


Fig 10. Typical Capacitance vs.Drain-to-Source Voltage

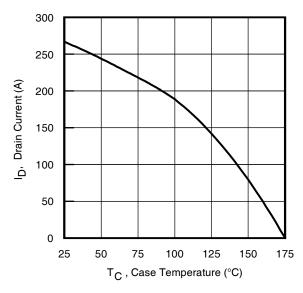


Fig 12. Maximum Drain Current vs. Case Temperature

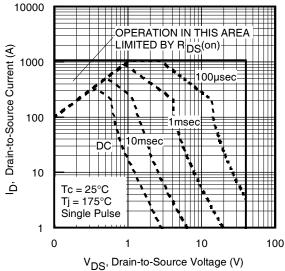


Fig 13. Maximum Safe Operating Area

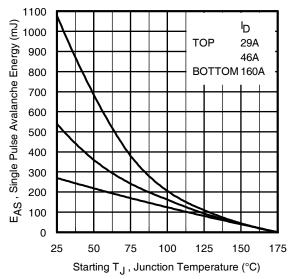


Fig 14. Maximum Avalanche Energy vs. Temperature

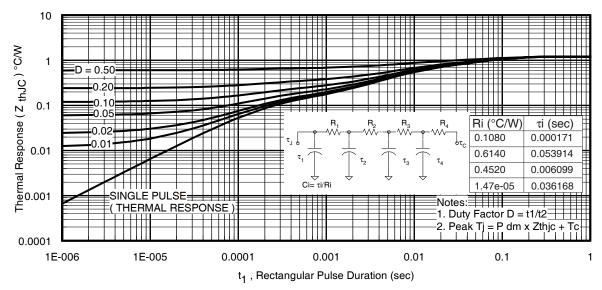


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

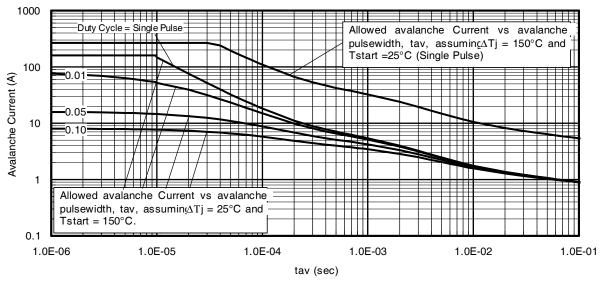


Fig 16. Typical Avalanche Current vs. Pulsewidth

International

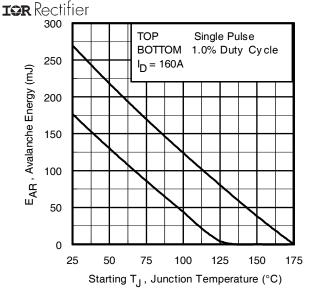


Fig 17. Maximum Avalanche Energy vs. Temperature

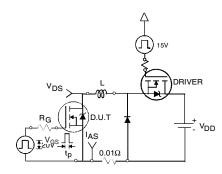


Fig 18a. Unclamped Inductive Test Circuit

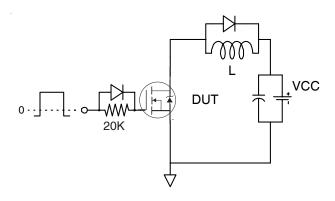


Fig 19a. Gate Charge Test Circuit

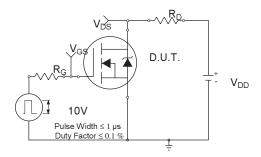


Fig 20a. Switching Time Test Circuit

AUIRF7739L2TR/TR1

Notes on Repetitive Avalanche Curves, Figures 13, 14: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. $P_{D \text{ (ave)}}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{imax} (assumed as 25°C in Figure 15, 16).

t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,IC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \triangle T/ \; Z_{thJC} \\ I_{av} &= 2\triangle T/ \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

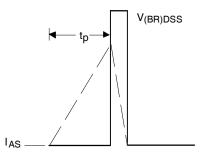


Fig 18b. Unclamped Inductive Waveforms

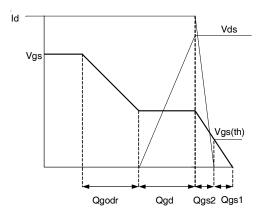


Fig 19b. Gate Charge Waveform

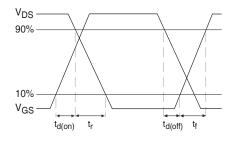


Fig 20b. Switching Time Waveforms

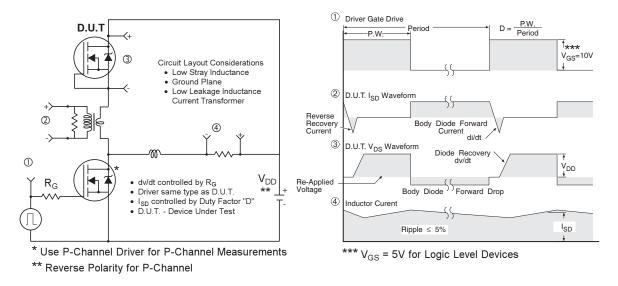
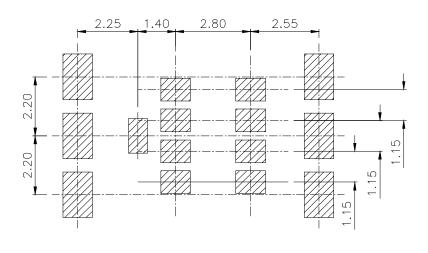
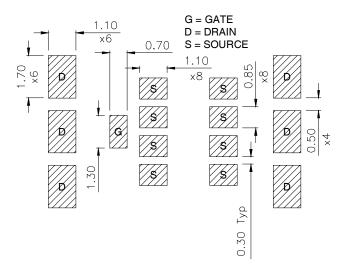


Fig 21. Diode Reverse Recovery Test Circuit for HEXFET® Power MOSFETs

Automotive DirectFET® Board Footprint, L8 (Large Size Can).

Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations



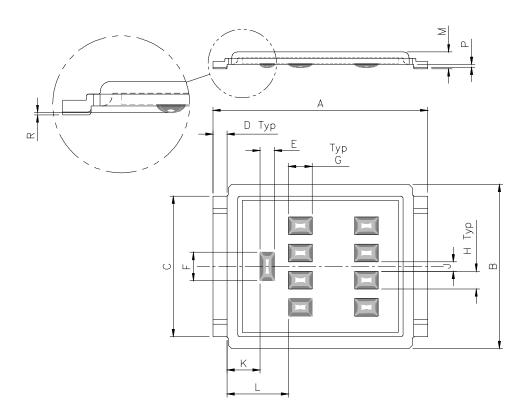


Note: For the most current drawing please refer to IR website at http://www.irf.com/package

AUIRF7739L2TR/TR1

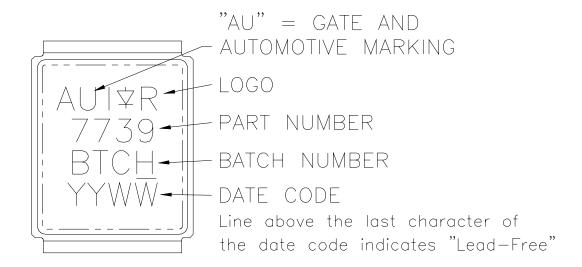
Automotive DirectFET® Outline Dimension, L8 Outline (LargeSize Can).

Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations



DIMENSIONS								
	MET	RIC	IMPE	RIAL				
CODE	MIN	MAX	MIN	MAX				
Α	9.05	9,15	0.356	0.360				
В	6.85	7.10	0.270	0.280				
С	5.90	6.00	0.232	0.236				
D	0.55	0.65	0.022	0.026				
Ε	0.58	0.62	0.023	0.024				
F	1,18	1.22	0,046	0.048				
G	0.98	1.02	0.039	0.040				
Н	0.73	0.77	0.029	0.030				
J	0.38	0.42	0.015	0.017				
K	1.35	1.45	0.053	0.057				
L	2.55	2.65	0.100	0.104				
М	0.68	0.74	0.027	0.029				
Р	0.09	0.17	0.003	0.007				
R	0.02	0.08	0.001	0.003				

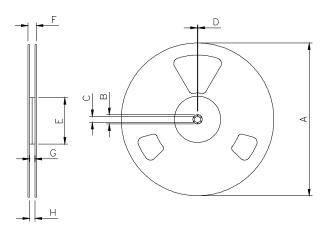
Automotive DirectFET® Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package www.irf.com

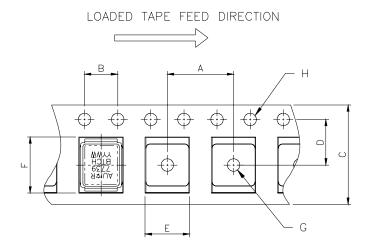
AUIRF7739L2TR/TR1

Automotive DirectFET® Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4000 parts. (ordered as AUIRF7739L2TR). For 1000 parts on 7" reel, order AUIRF7739L2TR1

REEL DIMENSIONS								
STANDARD OPTION(QTY 4000)					TR1 OPTION(QTY 1000)			
	MET	RIC	IMPE	RIAL	MET	RIC	IMPE	RIAL
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX
А	330.00	N.C	12.992	N.C	177.80	N.C	7,000	N.C
В	20.20	N.C	0.795	N.C	20.20	N.C	0.795	N.C
С	12.80	13.20	0.504	0.520	12.98	13.50	0.331	0.50
D	1.50	N.C	0.059	N.C	1.50	2.50	0.059	N.C
E	99.00	100.00	3.900	3.940	62.48	N.C	2.460	N.C
F	N.C	22.40	N.C	0.880	N.C	N.C	N.C	0.53
G	16.40	18.40	0.650	0.720	N.C	N.C	N.C	N.C
Τ	15,90	19.40	0.630	0.760	16.00	N.C	0.630	N.C



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS								
	MET	RIC	IMPERIAL					
CODE	MIN	MAX	MIN	MAX				
Α	11.90	12.10	4.69	0.476				
В	3.90	4.10	0.154	0.161				
С	15.90	16.30	0.623	0.642				
D	7.40	7.60	0.291	0.299				
Е	7.20	7.40	0.283	0.291				
F	9.90	10.10	0.390	0.398				
G	1.50	N.C	0.059	N.C				
Н	1.50	1.60	0.059	0.063				

Note: For the most current drawing please refer to IR website at http://www.irf.com/package

Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET® Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- $\ensuremath{\mathfrak{G}}$ T_C measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- © Starting $T_J = 25$ °C, L = 0.021mH, $R_G = 25Ω$, $I_{AS} = 160$ A.
- \bigcirc Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- ® Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- $^{\circledR}$ R_{θ} is measured at T_J of approximately 90°C.

International

TOR Rectifier

AUIRF7739L2TR/TR1

IMPORTANT NOTICE

Unless specifically designated for the automotive market, International Rectifier Corporation and its subsidiaries (IR) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or services without notice. Part numbers designated with the "AU" prefix follow automotive industry and / or customer specific requirements with regards to product discontinuance and process change notification. All products are sold subject to IR's terms and conditions of sale supplied at the time of order acknowledgment.

IR warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with IR's standard warranty. Testing and other quality control techniques are used to the extent IR deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

IR assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using IR components. To minimize the risks with customer products and applications, customers should provide adequate design and operating safeguards.

Reproduction of IR information in IR data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alterations is an unfair and deceptive business practice. IR is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of IR products or serviced with statements different from or beyond the parameters stated by IR for that product or service voids all express and any implied warranties for the associated IR product or service and is an unfair and deceptive business practice. IR is not responsible or liable for any such statements.

IR products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or in other applications intended to support or sustain life, or in any other application in which the failure of the IR product could create a situation where personal injury or death may occur. Should Buyer purchase or use IR products for any such unintended or unauthorized application, Buyer shall indemnify and hold International Rectifier and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that IR was negligent regarding the design or manufacture of the product.

IR products are neither designed nor intended for use in military/aerospace applications or environments unless the IR products are specifically designated by IR as military-grade or "enhanced plastic." Only products designated by IR as military-grade meet military specifications. Buyers acknowledge and agree that any such use of IR products which IR has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

IR products are neither designed nor intended for use in automotive applications or environments unless the specific IR products are designated by IR as compliant with ISO/TS 16949 requirements and bear a part number including the designation "AU". Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, IR will not be responsible for any failure to meet such requirements.

For technical support, please contact IR's Technical Assistance Center http://www.irf.com/technical-info/

WORLD HEADQUARTERS:

233 Kansas St., El Segundo, California 90245 Tel: (310) 252-7105

www.irf.com 11

AMEYA360 Components Supply Platform

Authorized Distribution Brand:

























Website:

Welcome to visit www.ameya360.com

Contact Us:

> Address:

401 Building No.5, JiuGe Business Center, Lane 2301, Yishan Rd Minhang District, Shanghai , China

> Sales:

Direct +86 (21) 6401-6692

Email amall@ameya360.com

QQ 800077892

Skype ameyasales1 ameyasales2

Customer Service :

Email service@ameya360.com

Partnership :

Tel +86 (21) 64016692-8333

Email mkt@ameya360.com